## Applicant(s)/Patent Under Application/Control No. Reexamination 10/644,143 SANCHEZ ET AL. Notice of References Cited Examiner Art Unit Page 1 of 1 1614 Frederick F. Krass **U.S. PATENT DOCUMENTS** Document Number Date Name Classification Country Code-Number-Kind Code MM-YYYY 514/217 02-2001 Evenden et al. US-6,184,219 Α Wong et al. 514/415 US-6,169,105 01-2001 В US-С D US-US-Ε US-F US-G US-Н US-1 US-J US-Κ US-L US-М FOREIGN PATENT DOCUMENTS Document Number Date Name Classification Country Country Code-Number-Kind Code MM-YYYY Ν 0 Ρ Q R S Т **NON-PATENT DOCUMENTS** Include as applicable: Author, Title Date, Publisher, Edition or Volume, Pertinent Pages) U W

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